NIKO-SEM

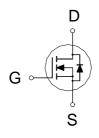
N-Channel Logic Level Enhancement Mode Field Effect Transistor

P3203CMG

Lead-Free

PRODUCT SUMMARY

$V_{(BR)DSS}$	R _{DS(ON)}	I _D		
30	32m	6A		





- 1. GATE
- 2. DRAIN
- 3. SOURCE

ABSOLUTE MAXIMUM RATINGS (T_c = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST	SYMBOL	LIMITS	UNITS		
Gate-Source Voltage		V _{GS}	±12	V	
Continuous Drain Current	T _C = 25 °C		6		
Continuous Diain Current	T _C = 70 °C	/ID/	5	Α	
Pulsed Drain Current ¹	I _{DM}	30			
Power Dissipation	T _C = 25 °C	D	1.25	W	
Power Dissipation	$T_C = 70 ^{\circ}C$	P _D	0.8	7 vv	
Operating Junction & Storage Tem	T_{j} , T_{stg}	-55 to 150	°C		
Lead Temperature (1/16" from case	71/	275			

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient	R _{eJA}	75	100	°C/W

¹Pulse width limited by maximum junction temperature.

ELECTRICAL CHARACTERISTICS (T_C = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL TEST CONDITIONS		LIMITS			UNIT
FARAMETER	STRIBOL	TEST CONDITIONS	MIN	TYP	MAX	OIVII
	\searrow	STATIC				
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250 \mu A$	30			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.45	0.75	1.2	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0V, V_{GS} = \pm 12V$			±100	nA
Zero Gate Voltage Drain Cyrrent	I _{DSS}	$V_{DS} = 24V, V_{GS} = 0V$			1	^
Zero Gate Voltage Drait Current		$V_{DS} = 20V, V_{GS} = 0V, T_{J} = 70 ^{\circ}C$			10	μА
On-State Drain Current ¹	I _{D(ON)}	$V_{DS} = 5V, V_{GS} = 4.5V$	30			Α
Drain-Source On-State	R _{DS(ON)}	$V_{GS} = 2.5V, I_D = 4A$		43	52	8
Resistance ¹		$V_{GS} = 4.5V, I_D = 5A$		27	32	m
		$V_{GS} = 10V, I_D = 6A$		23	28	

 $^{^2}$ Duty cycle $\leq 1\%$

NIKO-SEM

N-Channel Logic Level Enhancement Mode Field Effect Transistor

P3203CMG

Lead-Free

Forward Transconductance ¹	g fs	$V_{DS} = 5V$, $I_D = 5A$		15		S		
DYNAMIC								
Input Capacitance	C_{iss}			740				
Output Capacitance	C _{oss}	$V_{GS} = 0V, V_{DS} = 10V, f = 1MHz$		90		pF		
Reverse Transfer Capacitance	C_{rss}	^		66				
Total Gate Charge ²	Q_g			8/	12			
Gate-Source Charge ²	Q_{gs}	$V_{DS} = 0.5V_{(BR)DSS}, V_{GS} = 4.5V,$		3.6		nC		
Gate-Drain Charge ²	Q_{gd}	I _D = 5A	7 ~	72				
Turn-On Delay Time ²	t _{d(on)}			8	14			
Rise Time ²	t _r	$V_{DD} = 10V$		6	12	nS		
Turn-Off Delay Time ²	t _{d(off)}	$V_{DD} = 10V$, $I_{D} \cong 1A$, $V_{GEN} = 4.5V$, $R_{G} = 0.2$		19	45	113		
Fall Time ²	t _f			7	23			
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _c = 25 °C)								
Continuous Current	Is				1.3	Α		
Pulsed Current ³	I _{SM}				30	A		
Forward Voltage ¹	V _{SD}	$I_F \neq I_S$, $V_{SS} = 0V$			1.3	V		

¹Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

REMARK: THE PRODUCT MARKED WITH "1BYWW", DATE CODE or LOT #

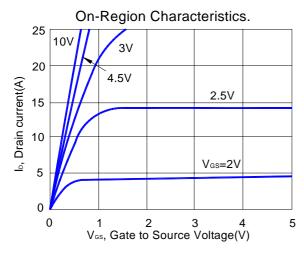
Orders for parts with Lead-Free plating can be placed using the PXXXXXXG parts name.



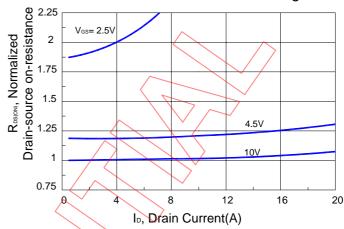
²Independent of operating temperature.

³Pulse width limited by maximum junction temperature.

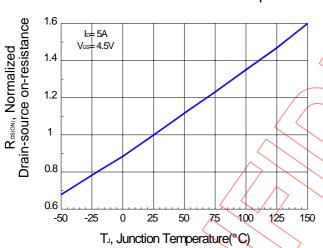
Typical Electrical Characteristics



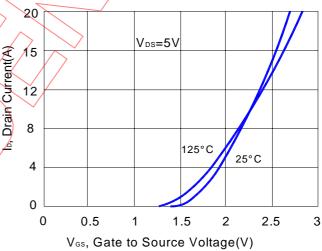
On-Resistance Variation with Drain Current and Gate Voltage.



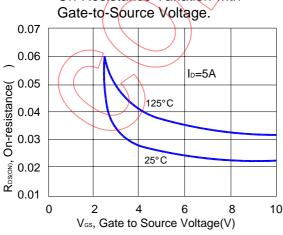
On-Resistance Variation with Temperature.



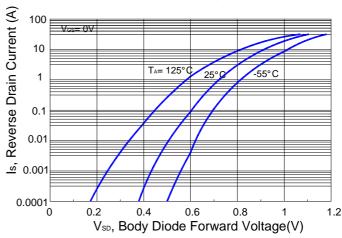
Transfer Characteristics.



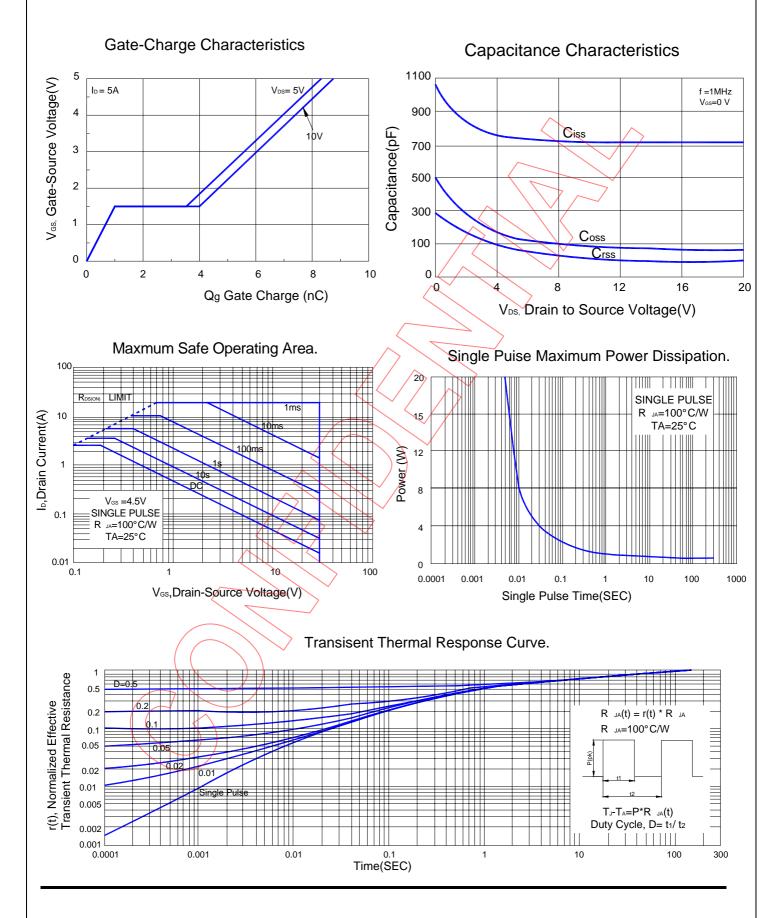
On-Resistance Variation with



Body Diode Forword Voltage Variation with Source Current and Temperature.



Lead-Free



Lead-Free

SOT-23 (M3) MECHANICAL DATA

Dimension	mm			Division	mm			
Dimension	Min.	Тур.	Max.	Dimension	Min.	Тур.	Max.	
А	0.85	0.95	1.15	Н	0.1	0.15	0.35	
В	2.4		3	I	0.2		0.6	
С	1.4	1.6	1.8	J				
D	2.7	2.9	3.1	К /		<u> </u>		
Е	0.9	1.1	1.4	L				
F	0		0.1	М				
G	0.3	0.4	0.5	N				

